

<b>Notice of References Cited</b>	Application/Control No. 10/578,056	Applicant(s)/Patent Under Reexamination SAYEH ET AL.	
	Examiner Khai M. Nguyen	Art Unit 2819	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,326,910	12-2001	Hayduk et al.	341/137
*	B	US-6,525,682	02-2003	Yap et al.	341/137
*	C	US-6,781,533	08-2004	Yap et al.	341/143
*	D	US-6,469,649	10-2002	Helkey et al.	341/155
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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